

## Transaction Information

Tool ID	PRS101
Tool Status	Disconnected
Location	Dresden, Germany
Wafer Size	300 mm
Fab Section	Test
Tool Available Date	2024-06-07

## General Product Information

Vendor Supplier	TEL
Model	Wafer Prober P12XLn
Vintage	2005
Serial No	PN00889
Asset Description	Wafer Prober 12"
Software Version	OEM/GF
CIM	NONE
Process	Wafer Test

## Hardware Configuration (Fab)

System Type	Description	Quantity	Status
Main System	Wafer Prober 12"	1	
Handler System	NA		
Factory Interface	FOUP	1	
Options System			

## Hardware Configuration (Subfab / Auxilliary Units)

Description	Quantity	Status
NONE		

## Missing/Faulty Parts / Accesories List

Description	Quantity
NONE	

## Tool Pictures

General

PRS101 total view (wrapped in foil)



Manufacture Serial

PRS101



**TOKYO ELECTRON LIMITED**

Manufacturer: TOKYO ELECTRON AT LIMITED  
Fuji Plant  
2381-1 Kitagejo, Fuji-cho Nirasaki-City, Yamanashi 407-8511 JAPAN

Model : P-12XIn Serial No: PN00889  
Manufactured : 2005, Apr Weight: 1874 kg  
Rated Power Input : AC 208 V 50/60 Hz 1  $\phi$  3.8k VA 19.0 A  
Rated Breaker Input : 30 A Ampere Interrupt Capacity : 35 kA  
Rated Maximum Motor: 100 VAC 50/60 Hz 1  $\phi$  900 VA 9.0 A  
Dry Air : 0.45 - 0.7 MPa 27  $\phi$ /min  
vacuum : - 0.05 MPa or less  
Reference Drawing : 3397 - 720039 - 23 MADE IN JAPAN

## Additional Configuration Files